

Notice of References Cited	Application/Control No. 10/621,126		Applicant(s)/Patent Under Reexamination SIRHAN ET AL.	
	Examiner (Jackie) Tan-Uyen T. Ho		Art Unit 3731	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,063,111	05-2000	Hieshima et al.	623/1.22
*	B	US-5,972,001	10-1999	Yoon, InBae	606/139
*	C	US-5,356,424	10-1994	Buzerak et al.	606/223
*	D	US-5,944,750	08-1999	Tanner et al.	623/1.23
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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